

**Search Notes**

Application/Control No.

10/619,827

Examiner

Mohamed Charioui

Applicant(s)/Patent under  
Reexamination

TICE, LEE D.

Art Unit

2857

**SEARCHED**

Class	Subclass	Date	Examiner
702	1, 69, 70, 71, 73-76	6/3/2005	MC
702	79, 124	6/3/2005	MC
702	189-191	6/3/2005	MC
702	195, 197	6/3/2005	MC
702	126, 193	6/3/2005	MC
340	506	6/3/2005	MC
340	335.05	6/3/2005	MC
Search	updated	11/14/2005	MC
Search	updated	2/16/2006	MC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
702	191	2/17/2006	MC
340	506	2/17/2006	MC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Hal Wachsman	6/3/2005	MC
East: (noise with sensor\$1 with (reduc\$6 or remov\$4 or eliminat\$6)) with (sampl\$4 near10 average)	6/3/2005	MC
East: (noise with sensor\$1 with (reduc\$6 or remov\$4 or eliminat\$6)) with (sampl\$4 with averag\$3)	6/3/2005	MC
Search updated	11/14/2005	MC
Search updated	2/16/2006	MC
East: (sampl\$4 near rate) with (number near samples) with averag\$3	2/16/2006	MC
East: (sampl\$4 near rate) with increas\$4 with (number near samples) with averag\$3	2/16/2006	MC